

Application/Control	No.
10/809,254	

Examiner Hai H. Huynh Applicant(s)/Patent under Reexamination
LIU ET AL.

Art Unit 3747

				ISSUE	CL	_AS	SIF	ICATI	ON					-	
		ORIGINAL		INTERNATIONAL CLASSIFICATION											
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	Claims										☐ CPA			☐ T.D.			☐ R.1.47		
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